

Product Change Notification / NTDO-16ZPQ0768

Date:

22-Feb-2022

Product Category:

USB Hubs

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4969 Initial Notice: Qualification of A194 lead frame material and new DAP surface prep for USB5806, USB5807, USB5816, USB5826, USB5906, USB5916 and USB5926 device families in 100L VQFN (12 x 12 x 0.9mm) package.

Affected CPNs:

NTDO-16ZPQ0768_Affected_CPN_02222022.pdf NTDO-16ZPQ0768_Affected_CPN_02222022.csv

Notification Text:

PCN Status:Initial Notification

PCN Type:Manufacturing Change

Microchip Parts Affected:Please open one of the files found in the Affected CPNs section. Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

Description of Change:Qualification of A194 lead frame material and new DAP surface prep for USB5806, USB5807, USB5816, USB5826, USB5906, USB5916 and USB5926 device families in 100L VQFN (12 x 12 x 0.9mm) package.

Pre and Post Change Summary:

		Pre Change	Post Change				
Assen	nbly Site	Microchip Technology Thailand (HQ) (MTAI)	Microchip Technology Thailand (HQ) (MTAI)				
Wire Material		CuPdAu	CuPdAu				
Die Attach Material		3280	3280				
Mold Comp	ound Material	G700	G700				
	Material	EFTEC64T	A194				
Leadframe	DAP Surface Prep	Double Ag ring plated	Single Ag ring plated				
	Treatment	Roughening	Roughening				
	Process	Etched	Etched				
	Plating	Matte Tin	Matte Tin				
	Design	See attached Pre and Post Change comparison.					

Impacts to Data Sheet:None

Change ImpactNone

Reason for Change:To improve manufacturability by qualifying A194 lead frame material and new DAP surface prep.

Change Implementation Status: In Progress

Estimated Qualification Completion Date: March 2022

Note: Please be advised the qualification completion times may be extended because of unforeseen business conditions however implementation will not occur until after qualification has completed and a final PCN has been issued. The final PCN will include the qualification report and estimated first ship date. Also note that after the estimated first ship date guided in the final PCN customers may receive pre and post change parts.

Time Table Summary:

	F	February 2022					March 2022				
Workweek	6	7	8	9	1 0		10	11	12	13	14
Initial PCN Issue Date				х							
Qual Report											Х

Availability						
Final PCN Issue						v
Date						Х

Method to Identify Change: Traceability code

Qualification Plan: Please open the attachments included with this PCN labeled as PCN_#_Qual_Plan.

Revision History: February 22, 2022: Issued initial notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN_NTDO-16ZPQ0768_Qual_Plan.pdf PCN_NTDO-16ZPQ0768_Pre and Post Change Summary.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our PCN home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the PCN FAQ section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

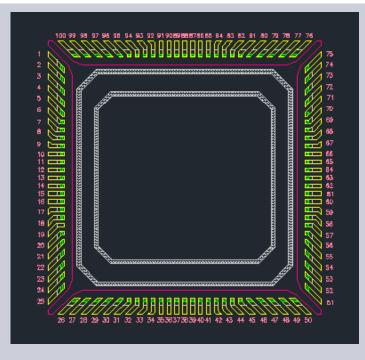
CCB 4969 Pre and Post Change Summary PCN #: NTDO-16ZPQ0768

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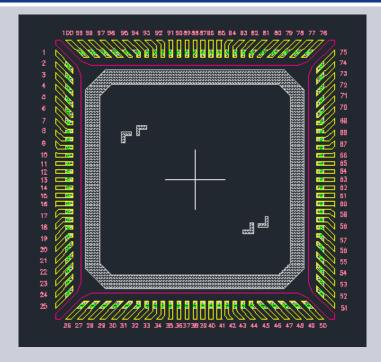
Leadframe Comparison

Pre Change



Leadframe Material	EFTEC64T
DAP Surface Prep	Double Ag ring plated
Lead Plating	Matte Tin

Post Change



Material	A194
DAP Surface Prep	Single Ag ring plated
Lead Plating	Matte Tin





QUALIFICATION PLAN SUMMARY

PCN #: NTDO-16ZPQO768

Date: January 19, 2022

Qualification of A194 lead frame material and new DAP surface prep for USB5806, USB5807, USB5816, USB5826, USB5906, USB5916 and USB5926 device families in 100L VQFN (12x12x0.9mm) package. Purpose: Qualification of A194 lead frame material and new DAP surface prep for USB5806, USB5807, USB5816, USB5826, USB5906, USB5916 and USB5926 device families in 100L VQFN (12x12x0.9mm) package.

	Assembly site	MTAI				
	Assembly site					
	BD Number	BD-000461 rev.01				
	MP Code (MPC)	STB07SKDXCH3				
	Part Number (CPN)	USB5807CT/KDH01				
	MSL information	MSL3/260				
<u>Misc.</u>	Assembly Shipping Media (T/R, Tube/Tray)	Tray & T/R				
	Base Quantity Multiple (BQM)	168 / 2500				
	Reliability Site	MTAI				
	CCB No.	4969				
	Paddle size	323x323				
	Material	A194				
	DAP Surface Prep	Ag ring plated on DAP				
Lead-Frame	Treatment	Roughening				
	Process	Etched				
	Lead-lock	No				
	Part Number	10110012				
	Lead Plating	Matte Tin				
Bond Wire	Material	CuPdAu				
Die Attech	Part Number	3280				
<u>Die Attach</u>	Conductive	Yes				
MC	Part Number	G700LTD				
	РКС Туре	VQFN				
<u>PKG</u>	Pin/Ball Count	100				
	PKG width/size	12x12x0.9 mm				

Test Name	Conditions	Sample Size	Min. Qty of Spares per Lot (should be properly marked)	Qty of Lot s	Total Units	Fail Accept Qty	Est. Dur Day s	Start Date	End Date	Test Site	Pkg. Type	Special Instructions
Wire Bond Pull - WBP	Mil. Std. 883-2011	5	0	1	5	0	5			MTAI		30 bonds from a min. 5 devices.
Wire Bond Shear - WBS	CDF-AEC-Q100-001	5	0	1	5	0	5			MTAI		30 bonds from a min. 5 devices.
External Visual	Mil. Std. 883-2009/2010	All devices prior to submission for qualification testing	0	3	ALL	0	5			MTAI		
Physical Dimensions	Measure per JESD22 B100 and B108	10	0	3	30	0	5			MTAI		
Preconditioning - Required for surface mount devices	+150°C Bake for 24 hours, moisture loading requirements per MSL level + 3X reflow at peak reflow temperature per Jedec- STD-020E for package type; Electrical test pre and post stress at +25C MSL3/260	231	15	3	738	0	15			ΜΤΑΙ		Spares should be properly identified.
HAST	+130°C/85% RH for 96 hours. Electrical test pre and post stress at +25°C and hot temp 105C	77	5	3	246	0	10			MTAI		Spares should be properly identified. Use the parts which have gone through Pre-conditioning.
UHAST	+130°C/85% RH for 96 hrs. Electrical test pre and post stress at 25°C	77	5	3	246	0	10			MTAI		Spares should be properly identified. Use the parts which have gone through Pre-conditioning.
Temp Cycle	-55°C to +125°C for 1,000 cycles. Electrical test pre and post stress at hot temp 105C; 3 grams force WBP, on 5 devices from 1 lot, test following Temp Cycle stress.	77	5	3	246	0	15			MTAI		Spares should be properly identified. Use the parts which have gone through Pre-conditioning.

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Affected Catalog Part Numbers (CPN)

USB5807/KD USB5806/KD USB5816/KD USB5906/KD USB5916/KD USB5926/KD USB5826/KD USB5807C/KD USB5806C/KD USB5816C/KD USB5826C/KD USB5906C/KD USB5916C/KD USB5926C/KD USB5816C/KDH01 USB5816C/KDH02 USB5807C/KDH01 USB5807-I/KD USB5806-I/KD USB5816-I/KD USB5906-I/KD USB5916-I/KD USB5926-I/KD USB5826-I/KD USB5807C-I/KD USB5806C-I/KD USB5816C-I/KD USB5826C-I/KD USB5906C-I/KD USB5916C-I/KD USB5926C-I/KD USB5816C-I/KDH02 USB5807C-I/KDH01 USB5807T/KD USB5806T/KD USB5816T/KD USB5906T/KD USB5916T/KD USB5926T/KD USB5826T/KD USB5807CT/KD USB5806CT/KD USB5816CT/KD USB5826CT/KD USB5906CT/KD USB5916CT/KD

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USB5926C1/KD
USB5806CT/KDD01
USB5816CT/KDH01
USB5816CT/KDH02
USB5807CT/KDH01
USB5807T-I/KD
USB5806T-I/KD
USB5816T-I/KD
USB5906T-I/KD
USB5916T-I/KD
USB5926T-I/KD
USB5826T-I/KD
USB5807CT-I/KD
USB5806CT-I/KD
USB5816CT-I/KD
USB5826CT-I/KD
USB5906CT-I/KD
USB5916CT-I/KD
USB5926CT-I/KD
USB5816CT-I/KDH02
USB5807CT-I/KDH01